## Notice of References Cited Application/Control No. 10/645,687 Examiner FARHAN M. SYED Applicant(s)/Patent Under Reexamination SIMELIUS ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,862,325 A	01-1999	Reed et al.	709/201
*	В	US-6,052,735 A	04-2000	Ulrich et al.	709/236
*	С	US-6,141,663 A	10-2000	Hunkins et al.	1/1
*	D	US-6,324,544 B1	11-2001	Alam et al.	1/1
*	Ε	US-2002/0090934 A1	07-2002	Mitchelmore, Eliott R.D.	455/412
*	F	US-2003/0119492 A1	06-2003	Timmins et al.	455/414
*	G	US-2003/0172113 A1	09-2003	Cameron et al.	709/204
*	Н	US-2003/0172168 A1	09-2003	Mak et al.	709/230
*	ı	US-2003/0182450 A1	09-2003	Ong et al.	709/246
*	J	US-6,732,090 B2	05-2004	Shanahan et al.	1/1
*	K	US-6,832,084 B1	12-2004	Deo et al.	455/419
*	L	US-7,496,606 B2	02-2009	Hind et al.	1/1
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

	NON-FATENT DOCUMENTS								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
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